Comment on "Interaction Effects in Conductivity of Si Inversion Layers at Intermediate Temperatures"

In a recent Letter [1], Pudalov et al. have claimed that they have found an excellent agreement between their experimental data and theory [2]. According to them, the anomalous (by an order of magnitude [3]) increase of resistance with temperature can be quantitatively described by the theory of small corrections arising from quantum coherent interaction effects. Notably, this claim negates previous publication [4] entitled "Exclusion of Quantum Coherence as the Origin of the 2D Metallic State in High-Mobility Silicon Inversion Layers", in which the same samples were studied in the same temperature and density ranges. The purpose of this Comment is to show that when analyzed correctly, the data of Pudalov et al. are not appropriate for accurate comparison with theory and do not allow one to distinguish between the interaction-based theory [2] and the traditional screening theory [5].

Despite theory [2] yields a linear-in-T correction to conductivity ( ), Pudalov et al. choose to analyze the temperature-dependent resistivity ( ). This serves to mask the fact that there is essentially no linear-in-T interval on their (T) dependences [6]. To demonstrate this, in Fig. 1 we plot (T) recalculated from the published (T) data for two lowest electron densities [7] shown in Fig. 1 (b) of Ref. [1]. The solid lines correspond to the slopes d /dT, which the authors claim to be in "excellent agreement" with their experimental data (circles). The obvious reason for the dramatic discrepancy between presentations of the data in the conductivity and resistivity forms are large changes of with temperature, reaching a factor of two.

Another point of importance is that the data of Ref. [1] are not related to the "anomalous increase of with temperature" as they are taken at (relatively) high electron densities $n_s > 2 \quad 10^{11}$ cm ^{2}, where interaction effects are weak. Metallic corrections to conductivity in this regime have been observed [8] and described by the traditional screening theory [5] long time ago. The same theory provides reasonably good fits to the current data from Ref. [1] (see, e.g., the dashed lines in Fig. 1). Note that at electron densities $\& 5 \quad 10^{11}$ cm ^{2}, theory [2] can hardly be applied at all to Si inversion layers because surface roughness scattering becomes dominant.

Summarizing, the comparison performed by Pudalov et al. [1] between experimental data (including those for the magnetoresistance) and theory [2] is not valid. Moreover, their data do not support the interaction-related origin of the metallic (T) at the relatively high electron densities used once both theories [2, 5] are treated on equal footing. As follows from accurate measurements in best samples [3, 9], the interactions become important at lower densities close to the metal-insulator transition, where they lead to a strong renormalization of the effective mass which corresponds to strongly temperature-dependent metallic resistivity.

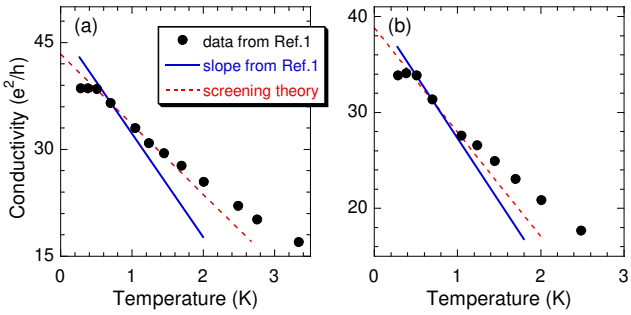

FIG. 1: Conductivity vs. temperature for $n_s = 2.46$ (a) and 2.23 10^{11} cm ^{2} (b) along with the slopes d /dT recalculated from d /dT of Ref. [1]. Also shown are the fits to the data using the traditional screening theory [5] with the effective mass values taken from Ref. [9].

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